Search Notes			

 Application/Control No.	Applicant(s)/Patent under Reexamination	
10/699,048	VANCE, SCOTT L.	
Examiner	Art Unit	
Leith A. Al-Nazer	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	702	5/24/2005	LA
343	700MS	5/24/2005	LA
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	702	5/24/2005	LA
343	700MS	5/24/2005	LA

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Updated EAST Text Search (see Examiner Search Notes)	5/24/2005	LA
Consulted primary examiner Hoang Nguyen	5/25/2005	LA